

Notice of References Cited

Application/Control No.

10/522,603

Applicant(s)/Patent Under
Reexamination
FUKUCHI ET AL.

Examiner

CATHERYNE CHEN

Art Unit

1655

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2007/0212460 A1	09-2007	Inoue et al.	426/268
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N	WO 00/24273	05-2000	PCT	Inoue et al.	-----
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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